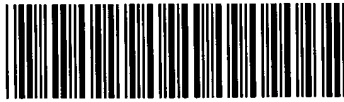


**Search Notes**

Application No.

09/826,922

Examiner

Matthew Haney

Applicant(s)

NAKASHIMA ET AL.

Art Unit

2613

**SEARCHED**

Class	Subclass	Date	Examiner
348	283	8/11/2004	MJH
348	281	8/11/2004	MJH
382	297	8/12/2004	MJH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Examiner Ngoc-Yen Vu - Gave Bryan Ackland reference from IEEE and patent search area 348/222	8/12/2004	MJH
Examiner Andy Christensen - Suggested 348/283 and to search "same" "common" or "single" with chip	8/11/2004	MJH
Attached are the Search History Notes	8/12/2004	MJH